# Root Cause Analysis: How can the Data help you ?

HI Reliability Seminar

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**Coen Smits** 

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#### **POWERFUL** SOLUTIONS

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## Statistical Engineering: Collapsed Ballast Coils Case

- Problem Coil inner dimension won't fit over lamination stack if it collapses.
  - Adjust winding machine tension
  - Change material
- DoE approach (e.g. Tension, Material, Winding speed, etc.)
- Result Production continues scrapping coils





Coil

Lamination stack

### Solution: Collapsed Ballast Coils





Lamination stack



- Major Root Cause:
  - Interaction of lamination stack height and copper coil ID.
  - Stack height variability not recognized because of prior work.
- Result:
  - Coil scrap reduced from 4% to < 2% (\$75K/yr)
  - Solved in 1 Hour
- Lesson Learned:
  - Break through by thinking backwards
  - "Effect-Cause Relationship"

## Statistical Engineering: reasoning & documentation





### General RCA approaches

- Lucky guess
- First shot based on experience
  - Not used within SE

- Inefficient for new problems
- May guide in a false direction

- Suitable for known problems
- Requires a well-kept database

- Split root cause parameter space
- Exclude all options but one

• Find symptoms in a library

Limited use within SE

• E.g. common software issues

• Can be done on any basis

- Dedicated experiments
- Stepwise problem solving
- Backbone of SE



Branch & prune





## General RCA approaches

#### Proximate Causes

- Work from effect to cause in steps by backward reasoning
- Basis for approaches like 5 x Why
- Limited use within SE near the end of the investigation
- GP-TP Analysis and Group Comparison are based on this
- Used within SE when the list of remaining potential Root Causes is short

### Syndrome driven

 Find commonalities among instances of the same problem
Basis for approaches like Kepner-Tregoes Is-Is not

Funneling – Hypothesis testing

- Starts with an enumerable list
- Efficiency-driven experiments
- Often combined with DOE

#### • Basis for "Logic splits" in SE







Statistical Engineering seeks focus first; then create dedicated data "Branch and prune"

VS

### Data Science can process large amounts of data to find patterns "Syndrome-driven"

### Mismatch??

How can we make Data Science and Statistical Engineering work together?

# Going together: data science & statistical engineering



- Although at first sight there seems not to be a lot of interaction between statistical engineering and data science, still several possibilites exist
- Some examples amongst others:
  - 1. Focus on a specific problem / failure mode
  - 2. Mapping processes
  - 3. Multi-Vari Charts

# 1. Project definition: focussing on a problem



- In any Root Cause it is important to define what problem will be solved exactly
- Often many problems are present
  - E.g. for the performance indicator "availability loss" many different failure modes will contribute
  - Before solving any problem we need knowledge on the relative magnitude of all issues



## Data science can help to focus





### 2. Process breakdown

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RFID	Length		Width		Duration		Temperature		Relative humidity			
af-ed-90-3a	79.99		44.98		00:00:05		20.1		39.8			
af-ed-90-3b	79.97		44.98		00:00:05		20.1			39.7	Э.7	
af-ed-90-3c	79 <b>7</b>		ne ne	Dro	sura	Ton			ation	39.8		
af-ed-90-3d	<mark>) −79</mark>	08.00.12		2.5		20.9		00.00.15		39.7		
af-ed-90-3e	80	00.00.12		2.5			20.9		00.15	39.6		
af-ed-90-3f	80	08.0	10.59				20.9	00.	00.10	39.8		
af-ed-90-40	80	00.01.09			Time		RFID		Itage	Current		Power
af-ed-90-41	80	00.0	2.06	08	3:04:37	af	-ed-90-3a	1	1.99	0.0186	0.	222964
af-ed-90-42	80	08:0	02:00	08	3:04:50	af	-ed-90-3b	12	2.00	0.0156	0.	186993
af-ed-90-43	80	08:0	02:33	08	3:04·57		ed-90-3c	12	2.00	0.0113	0.	135278
af-ed-90-44	80	08:0	00:50	08	3:04:57	af	-ed-90-3d	12	2.00	0.0083	0.	099619
af-ed-90-45	80	08:0	3:30	08	3:05:06	af	ed-90-3e	12	2.00	0.0245	0	.29435
af-ed-90-46	79	08:0	13:57	08	3:05:12	af	-ed-90-40	12	2.00	0.0216	0	.25865
af-ed-90-47	80	08:0	)4:24	08	3:05:18	af	-ed-90-3f	1	1.99	0.0061	0.	072991
af-ed-90-48	79	08:0	)4:53	08	3:05:27	af	-ed-90-41	12	2.02	0.0196	0.	236099
af-ed-90-49	80	08:0	)5:20	08	3:05:33	af	-ed-90-42	1	1.99	0.0209	0.	250766
af-ed-90-4a	79	08:0	)5:49	08	3:05:45	af	-ed-90-43	12	2.02	0.0162	0.	194201
af-ed-90-4b	80	08:0	6:17	08	3:05:47	af	-ed-90-45	12	2.00	0.0091	0.	109494
af-ed-90-4c	79	08:0	6:45	08	3:05:54	af	-ed-90-44	12	2.00	0.0090	0.	107406
af-ed-90-4d	79	08:0	)7:13	08	3:06:02	af	-ed-90-46	12	2.00	0.0173	0.	207483
		08:0	)7:41	08	3:06:06	af	-ed-90-47	12	2.00	0.0113	0.	135253
	RFID     af-ed-90-3a     af-ed-90-3b     af-ed-90-3c     af-ed-90-40     af-ed-90-41     af-ed-90-42     af-ed-90-43     af-ed-90-44     af-ed-90-45     af-ed-90-46     af-ed-90-48     af-ed-90-48     af-ed-90-48     af-ed-90-48     af-ed-90-48     af-ed-90-4b     af-ed-90-4b     af-ed-90-4c     af-ed-90-4c	RFID     Leng       af-ed-90-3a     79       af-ed-90-3b     79       af-ed-90-3c     79       af-ed-90-3c     79       af-ed-90-3c     79       af-ed-90-3c     79       af-ed-90-3c     79       af-ed-90-3c     80       af-ed-90-3c     80       af-ed-90-41     80       af-ed-90-42     80       af-ed-90-43     80       af-ed-90-44     80       af-ed-90-45     80       af-ed-90-46     79       af-ed-90-47     80       af-ed-90-48     79       af-ed-90-47     80       af-ed-90-48     79       af-ed-90-49     80       af-ed-90-48     79       af-ed-90-48     79       af-ed-90-49     80       af-ed-90-48     79       af-ed-90-49     80       af-ed-90-40     79       af-ed-90-40     79       af-ed-90-40     79       af-ed-90-40     79  a	RFID     Length       af-ed-90-3a     79.99       af-ed-90-3b     79.97       af-ed-90-3c     79       af-ed-90-3c     79       af-ed-90-3c     79       af-ed-90-3c     79       af-ed-90-3c     79       af-ed-90-3c     80       af-ed-90-3c     80       af-ed-90-3c     80       af-ed-90-4c     80       af-ed-90-4d     79       af-ed-90-4d     79       af-ed-90-4d     79       af-ed-90-4d     79       af-ed-90-4d     79	RFID   Length   Widt     af-ed-90-3a   79.99   44.     af-ed-90-3b   79.97   44.     af-ed-90-3c   79   44.     af-ed-90-3c   79   08.     af-ed-90-3c   79   08.   12     af-ed-90-3c   80   08.   12     af-ed-90-3c   80   08.   139     af-ed-90-3c   80   08.   139     af-ed-90-41   80   08.   139     af-ed-90-42   80   08.   139     af-ed-90-43   80   08.   130     af-ed-90-43   80   08.   130     af-ed-90-44   80   08.   130     af-ed-90-45   80   08.   130     af-ed-90-45   80   08.   130     af-ed-90-45   80   08.   130     af-ed-90-46   79   08.   153     af-ed-90-47   80   08.   153     af-ed-90-48   79   08.   153     af-ed-90-49   80   08.   173	RFIDLengthWidthaf-ed-90-3a79.9944.98af-ed-90-3b79.9744.98af-ed-90-3c79 $1 + 3 + 3 + 3 + 3 + 3 + 3 + 3 + 3 + 3 + $	RFIDLengthWidthDurationaf-ed-90-3a79.9944.9800:00af-ed-90-3b79.9744.9800:00af-ed-90-3c79TimePressureaf-ed-90-3c79 $08:0:12$ 2.5af-ed-90-3c80 $08:0:39$ 2.5af-ed-90-3f80 $08:0:39$ 2.5af-ed-90-4080 $08:0:39$ 2.5af-ed-90-4180 $08:0:39$ 2.5af-ed-90-4280 $08:0:30$ $08:04:37$ af-ed-90-4380 $08:0:300$ $08:04:57$ af-ed-90-4480 $08:03:30$ $08:04:57$ af-ed-90-4580 $08:03:57$ $08:05:12$ af-ed-90-4679 $08:03:57$ $08:05:12$ af-ed-90-4780 $08:05:20$ $08:05:12$ af-ed-90-4879 $08:05:47$ $08:05:47$ af-ed-90-4879 $08:05:47$ $08:05:47$ af-ed-90-4479 $08:05:47$ $08:05:47$ af-ed-90-4580 $08:05:47$ $08:05:47$ af-ed-90-4679 $08:05:47$ $08:05:47$ af-ed-90-4879 $08:05:47$ $08:05:47$ af-ed-90-4479 $08:05:47$ $08:05:47$ af-ed-90-4479 $08:05:47$ $08:05:47$ 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- Explicitly: via tracing / RFID
- Implicitly: via repeatedly measured properties, timing, etc.



## 3. Multi-vari charts

- In SE Multi-Vari the variation is split into "families"
  - Within product
  - Between product
  - Over time
- A family is a partioning of the root cause parameter space
- By determining which family the root cause lives in, one can exclude whole classes of potential root causes





### Data science and multivari



- Actually, a multi vari is already Data Science, only with small data sets
- Data science may be used to extract the Multi Vari data from large quality control data sets, turning *"big data"* into *"right data"*
- One step further, Data Science can help finding contrasts over time or process structure, thereby suggesting relevant families of variation
  - This can go as far as predicting their relative magnitude
  - It becomes even more powerful if you combine this with the process flow analysis mentioned before, i.e., a multivari analysis for each process step
  - Caution however, process steps may be confounded if using production data

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- Conclusion
- Although Data Science and Statistical Engineering seem opposites at first sight, Data Science can strengthen the SE approach
- Data Science can quickly sift through the hay stack
- ... while Statistical Engineering ensures you're looking at the right hay stack







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# ACADEMY

# Problem Solving through Root Cause Analysis – Statistical Engineering



Major Root Cause Paradigm







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# Problem Solving through RCA

- StatEng course

# With this course (5 modules of 1 day) you'll learn:

- How the Statistical Engineering methodology works
- How to deal with failing products and how to report progress to management
- To become a complete problem solver

The Statistical Engineering (SE) methodology helps to create the starting grid for problem analysis and to understand a measurement system. It provides insight into which products and data to investigate and which statistical tools to use for that.

<u>https://www.holland-</u> <u>innovative.nl/academy/rf10-problem-</u> <u>solving-root-cause-analysis/</u>

#### Click here for more information

#### Problem Solving through Root Cause Analysis

Does one of the following sound familiar? "We are not sure whether we really solved the problem." "The root cause analysis team has been trying many things but nothing seems to work." "We do not have enough resources for root cause analysis." In that case our training Problem Solving by Statistical Engineering will give insight how to get out of the impasse, following state-of-the-art techniques.

#### Problem Solving by using Statistical Engineering

Register: www.holland-innovative.nl

#### The aim and result of the training

This training focusses on using a structured and efficient root cause analysis to solve the problems in your product. Processes commonly result in a certain spread on the output - i.e. the function of your products - causing a number of products to not fulfill the requirements and thus have a problem. The participants are trained to be able to perform a root cause analysis for problem solving using the Statistical Engineering (SE) methodology in an independent and professional manner. The SE methodology exploits the fact

that one root cause always has the largest contribution to the problem and the goal is to find this Root Cause and to understand it. The subsequent solution then becomes apparent.

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#### A selection of the skills that will be acquired

This training will make clear to you why and how the SE methodology works. This methodology helps to create the starting grid for a problem analysis and to understand a measurement system. Furthermore, it provides insight in which products and data to investigate and which statistical tools to use. The SE methodology includes many special tools that will be taught extensively during this training. Participants will learn how to deal with failing products and how to report progress to management. The training provides a complete program to become a complete problem solver.

#### Target group

This training aims at all engineers and specialists working in technical areas. The training is specifically meant for those who want to learn the efficient root cause analysis methods and be able to apply them in their own organization.

#### In-company

Holland Innovative offers this training also as an in-company training, with an option to include on-the-job coaching on ongoing problem solving projects. The training can be tailored to needs when necessary.

Course duration and number of participants 10 Half day sessions spread over 5 or 10 days. Maximum group size: 12 participants. Instructors Dr. Ko Dousma, Dr. Ir. Coen Smits

Location and investment Holland Innovative, High Tech Campus 29, Eindhoven. The Investment Is €3:500- (ex. VAI) per participant. This includes the 5 training days, a syllabus of the training material, templates and tools, lunch and refreshments. The training can also be given in-company. The training can be tailored to the requirements and vishes of the company.

Dates, registration and more info See www.holland-Innovative.n under Academy.

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